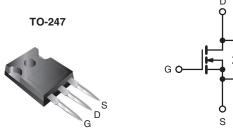
Vishay Siliconix



Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	400				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.30			
Q _g (Max.) (nC)	150				
Q _{gs} (nC)	23				
Q _{gd} (nC)	80				
Configuration	Single				



N-Channel MOSFET

FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP350PbF
	SiHFP350-E3
SnPb	IRFP350
	SiHFP350

ABSOLUTE MAXIMUM RATINGS $T_{C} = 25 \text{ °C}$, unless otherwise noted							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			V _{DS}	400	V		
Gate-Source Voltage			V _{GS}	± 20	v		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	1	16			
	VGS at 10 V	$T_C = 100 \ ^\circ C$	I _D	10	А		
Pulsed Drain Current ^a			I _{DM}	64			
Linear Derating Factor				1.5	W/°C		
Single Pulse Avalanche Energy ^b			E _{AS}	390	mJ		
Repetitive Avalanche Current ^a			I _{AR}	16	А		
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ		
Maximum Power Dissipation	T _C = 25 °C			P _D 190			
Peak Diode Recovery dV/dt ^c			dV/dt	4.0	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C			
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
			-	1.1	N · m		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 2.7 mH, $R_G = 25 \Omega$, $I_{AS} = 16 \text{ A}$ (see fig. 12). c. $I_{SD} \le 16 \text{ A}$, $dI/dt \le 200 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RAT	FINGS							
PARAMETER	SYMBOL	TYP. MAX		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 40 0.24 - - 0.65						
Case-to-Sink, Flat, Greased Surface	R _{thCS}				°C/W			
Maximum Junction-to-Case (Drain)	R _{thJC}							
SPECIFICATIONS $T_J = 25 \text{ °C}, $	unless otherw	vise noted						
PARAMETER	SYMBOL	1		IONS	MIN.	TYP.	MAX.	UNIT
Static					I	1	I	I
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	250 μΑ	400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.51	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}		= V _{GS} , I _D = 2		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$			-	± 100	nA
		V _{DS} = 400 V, V _{GS} = 0 V		$_{6} = 0 V$	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}			′, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	1	= 9.6 A ^b	-	-	0.30	Ω
Forward Transconductance	g fs	V _{DS} =	= 50 V, I _D =	9.6 A ^b	10	-	-	S
Dynamic		1					1	
Input Capacitance	C _{iss}		$V_{ee} = 0 V$		-	2600	-	
Output Capacitance	C _{oss}		$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	660	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	250	-		
Total Gate Charge	Qg				-	-	150	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		v, V _{DS} = 320 V, g. 6 and 13 ^b	-	-	23	
Gate-Drain Charge	Q _{gd}	1	300 h	g. o and to	-	-	80	
Turn-On Delay Time	t _{d(on)}		•		-	16	-	
Rise Time	tr		V _{DD} = 200 V, I _D = 16 A,		-	49	-	
Turn-Off Delay Time	t _{d(off)}	$\overline{R}_{G} = 6.2 \Omega, R_{D} = 12 \Omega$ see fig. 10^{b}		-	87	-	ns	
Fall Time	t _f			-	47	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH	
Internal Source Inductance	L _S			-	13	-		
Drain-Source Body Diode Characteristic	S				1		1	1
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	16	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	64		
Body Diode Voltage	V _{SD}	$T_J = 25 \text{ °C}, I_S = 16 \text{ A}, V_{GS} = 0 \text{ V}^{b}$		-	-	1.6	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_{\rm J} = 25 ^{\circ}\text{C}, I_{\rm F} = 16 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^{\rm b}$		1. 100 t/ h	-	380	570	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	4.7	7.1	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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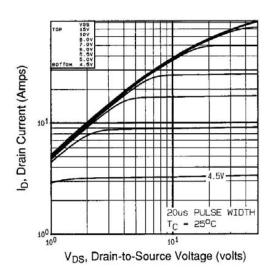


Fig. 1 - Typical Output Characteristics, $T_C = 25 \ ^{\circ}C$

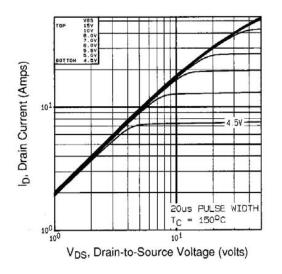


Fig. 2 - Typical Output Characteristics, $T_C = 150 \ ^\circ C$

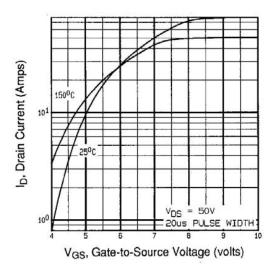


Fig. 3 - Typical Transfer Characteristics

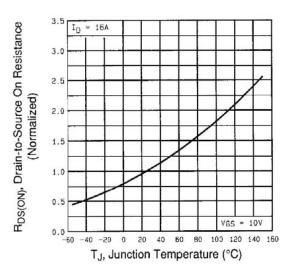


Fig. 4 - Normalized On-Resistance vs. Temperature

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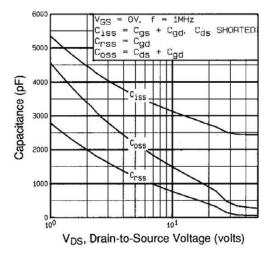
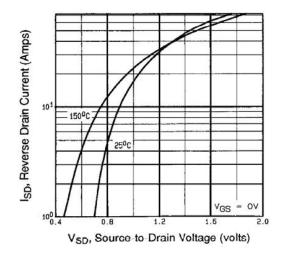


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





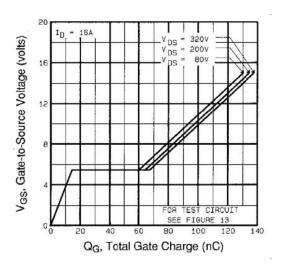


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

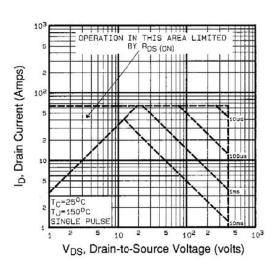


Fig. 8 - Maximum Safe Operating Area



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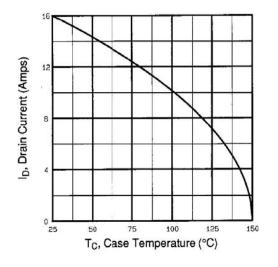


Fig. 9 - Maximum Drain Current vs. Case Temperature

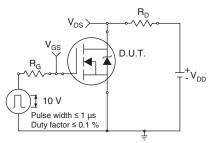


Fig. 10a - Switching Time Test Circuit

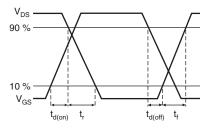


Fig. 10b - Switching Time Waveforms

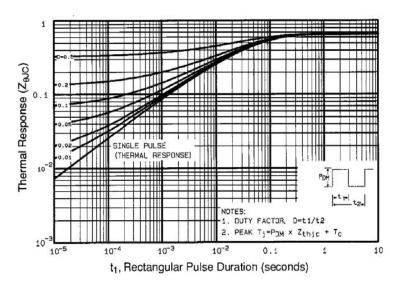


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

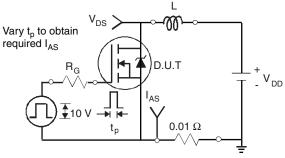


Fig. 12a - Unclamped Inductive Test Circuit

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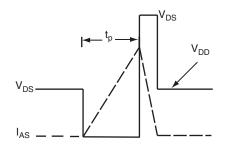


Fig. 12b - Unclamped Inductive Waveforms

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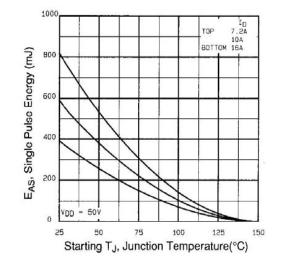


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

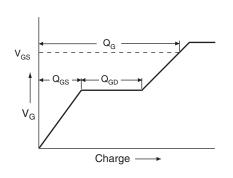


Fig. 13a - Basic Gate Charge Waveform

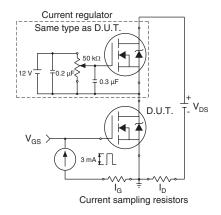
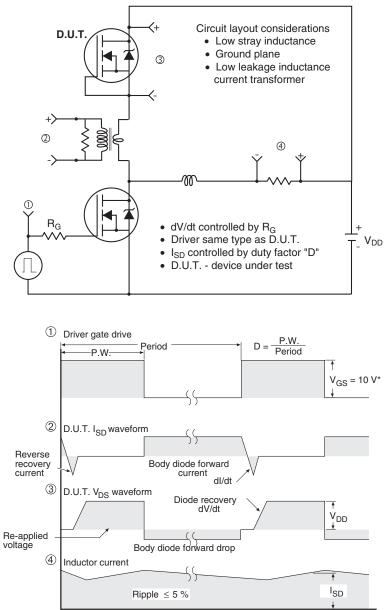


Fig. 13b - Gate Charge Test Circuit

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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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